

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination RIES ET AL.	
		10/049,196	Examiner	Art Unit 1625

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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	F	US-			
	G	US-			
	H	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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